JC20 Rec'd PCT/PTO 02 JUN 2005

Sheet 1 Of 1

FORM PTO-1449 (REV. 7-80) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

1 0 p/u5 70 5033.1012 To be assign

APPLICANT

Werner KNEBEL et al.

FILING DATE GROUP

(Use several sheets if necessary)

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Subs	titute for form 1449A/	B/PTO		Complete if Known			
0004		J		Application Number	10/537,335-Conf. #3451		
IN	FORMATION	ON DISC	CLOSURE	Filing Date	October 17, 2005		
S	TATEMEN'	T BY AP	PLICANT	First Named Inventor	Wemer Knebel		
				Art Unit	2877		
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